Power MOSFET

-20 V, -4.0 A, μCool™ Dual P-Channel, ESD, 2x2 mm WDFN Package

Features

- WDFN 2x2 mm Package with Exposed Drain Pads for Excellent Thermal Conduction
- Lowest R_{DS(on)} Solution in 2x2 mm Package
- Footprint Same as SC-88 Package
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- ESD Protected
- This is a Pb-Free Device

Applications

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li-Ion Battery Charging and Protection Circuits
- High Side Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	-20	V	
Gate-to-Source Voltage			V_{GS}	±8.0	V
Continuous Drain	Steady State	T _A = 25°C	I_{D}	-3.2	Α
Current (Note 1)		T _A = 85°C		-2.3	
	t ≤ 5 s	T _A = 25°C		-4.0	
Power Dissipation (Note 1)	Steady State T _A = 25°C		P _D	1.5	W
	t ≤ 5 s			2.3	
Continuous Drain		T _A = 25°C	I _D	-2.2	Α
Current (Note 2)	Steady	T _A = 85°C		-1.6	
Power Dissipation (Note 2)	State	T _A = 25°C	P _D	0.71	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	-16	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to 150	ô	
Source Current (Body Diode) (Note 2)			I _S	-1.0	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

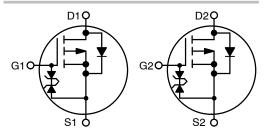
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm², 2 oz Cu.



ON Semiconductor®

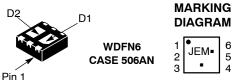
http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX (Note 1)
	100 mΩ @ -4.5 V	
-20 V	144 mΩ @ –2.5 V	-4.0 A
	200 mΩ @ –1.8 V	



P-CHANNEL MOSFET

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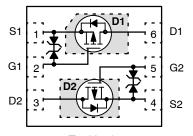
JE = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJD3181PZTAG	WDFN6 (Pb-Free)	3000/Tape & Reel
NTLJD3181PZTBG	WDFN6 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
SINGLE OPERATION (SELF-HEATED)	•		
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W
Junction-to-Ambient – $t \le 5 s$ (Note 3)	$R_{ hetaJA}$	54	
DUAL OPERATION (EQUALLY HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	58	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	133	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 3)	$R_{ hetaJA}$	40	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I_D = -250 μ A, Ref to 25°C			13		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	T _J = 85°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm$	8.0 V			±10	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = -2$	50 μΑ	-0.4		-1.0	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.0		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ V}$	-2.0 A		68	100	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -2.0 \text{ A}$			90	144	
		V _{GS} = -1.8 V, I _D = -1.7 A			125	200	
Forward Transconductance	9 _{FS}	$V_{DS} = -5.0 \text{ V}, I_D = -2.0 \text{ A}$			6.5		S
CHARGES, CAPACITANCES AND GA	TE RESISTANO	CE					•
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$			450		pF
Output Capacitance	C _{OSS}				90		
Reverse Transfer Capacitance	C _{RSS}				62		
Total Gate Charge	Q _{G(TOT)}				5.2	7.8	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -3.8 \text{ A}$			0.3		-
Gate-to-Source Charge	Q _{GS}				0.84		
Gate-to-Drain Charge	Q_{GD}				1.5		1
SWITCHING CHARACTERISTICS (No	te 6)				•		
Turn-On Delay Time	t _{d(ON)}				6.6		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} = -	–5.0 V.		9.0		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = -2.0 \text{ A}, R_G = 2.0 \Omega$			14		1
Fall Time	t _f				12.5		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•		·
Forward Recovery Voltage	V_{SD}	V _{GS} = 0 V, IS = -1.0 A	T _J = 25°C		-0.73	-1.0	V
			T _J = 125°C		-0.62		
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d_{ISD}/d_t = 100 A/ μ s, I_S = -1.0 A			23		1
Charge Time	t _a				13		ns
Discharge Time	t _b				10		
Reverse Recovery Time	Q _{RR}				10		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES ($T_J = 25^{\circ}C$ unless otherwise noted)

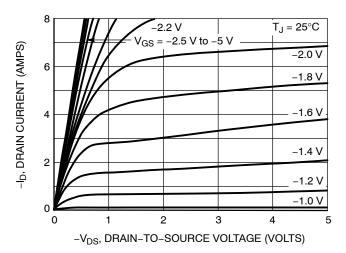


Figure 1. On-Region Characteristics

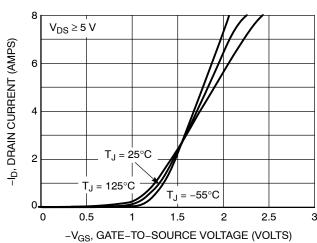


Figure 2. Transfer Characteristics

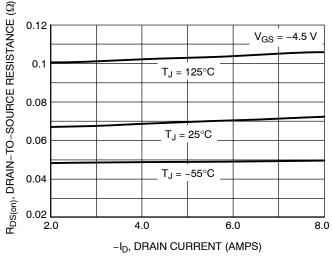


Figure 3. On-Resistance versus Drain Current

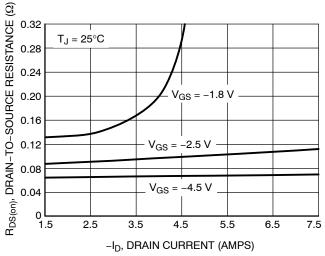


Figure 4. On-Resistance versus Drain Current and Gate Voltage

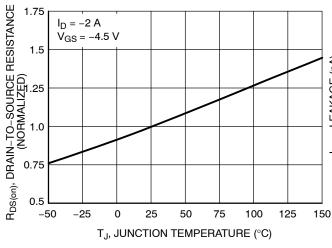


Figure 5. On–Resistance Variation with Temperature

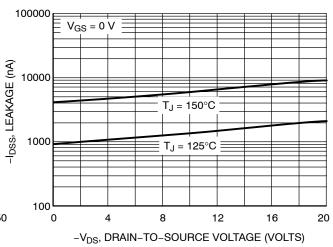


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

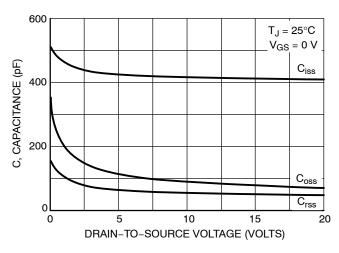


Figure 7. Capacitance Variation

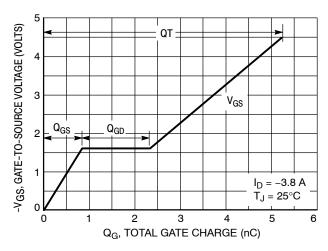


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

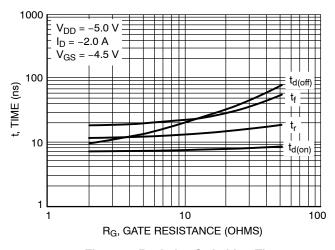


Figure 9. Resistive Switching Time Variation versus Gate Resistance

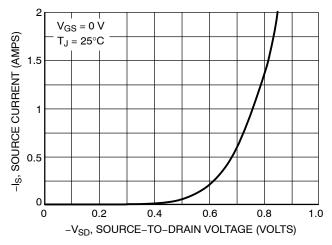


Figure 10. Diode Forward Voltage versus Current

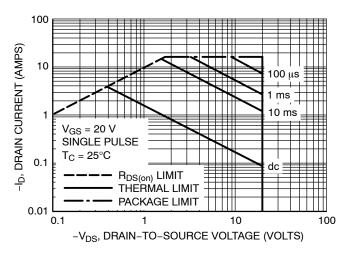


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL PERFORMANCE CURVES (T $_{J}$ = 25°C unless otherwise noted)

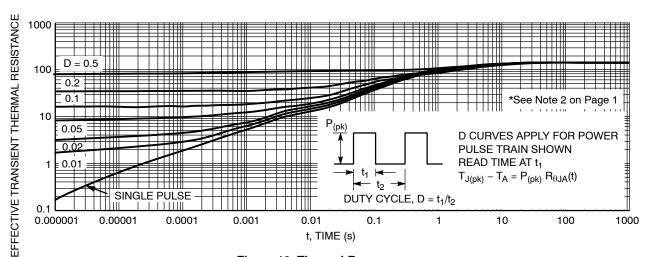
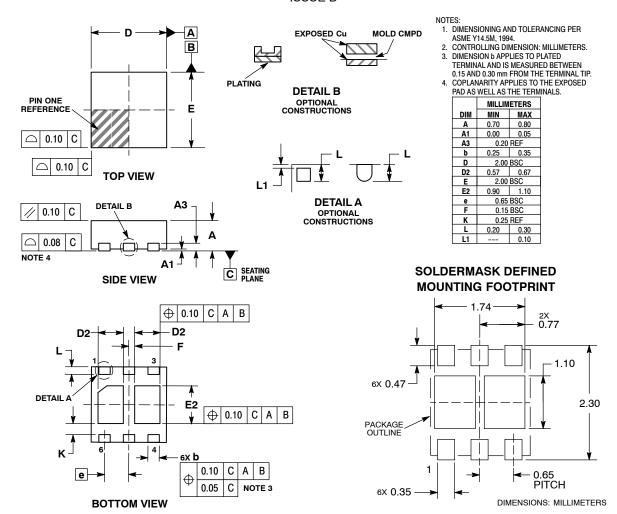


Figure 12. Thermal Response

PACKAGE DIMENSIONS

WDFN6, 2x2 CASE 506AN-01 ISSUE D



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